



<p>Searched</p> 	<p>Application/Control No.</p> <p>10045085</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>MIURA ET AL.</p>
	<p>Examiner</p> <p>Vincent, Sean E</p>	<p>Art Unit</p> <p>1731</p>

Class	Sub Class	Date	Examiner
264	414 432 (up to date)	3/7/05	SV

U.S. Patent and Trademark Office	Part of Paper No.: 3-14-05
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